

Application/Control No.	Applicant(s)/Pate Reexamination	ent under
10/722,887	LANEY ET AL.	
Examiner	Art Unit	
Patrick Butler	1791	

SEARCHED					
Class	Subclass	Date	Examiner		
264	46.1	9/12/2005	РВ		
264	45.9	9/12/2005	РВ		
264	290.2	9/12/2005	РВ		
264	177.2	9/12/2005	РВ		
264	211	9/12/2005	РВ		
264	173.11	9/12/2005	РВ		
264	173.16	9/12/2005	РВ		
428	221	9/12/2005	РВ		
428	307.3	9/12/2005	РВ		
264	291	9/12/2005	РВ		
Above	UPDATED	4/27/2006	РВ		
Above	UPDATED	12/6/2006	РВ		
Above	UPDATED	5/22/2007	/PB/		
Above	UPDATED	11/3/2009	/PB/		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
conducted inventor search in PALM	9/12/2005	РВ		
EAST(US-PGPUB; USOCR; USPAT; EPO; DERWENT; JPO, IBM_TDB) - See Search History Printout	9/12/2005	PB		
Consulted Mark Eashoo on 264	8/30/2005	РВ		
EAST(US-PGPUB; USOCR; USPAT) - See Search History Printout	4/27/2006	РВ		
EAST(US-PGPUB; USOCR; USPAT; DERWENT; EPO; JPO; IBM_TDB; FPRS) - See Search History Printout	12/6/2006	РВ		
EAST(US-PGPUB; USOCR; USPAT) - See Search History Printout	5/22/2007	/PB/		
EAST(US-PGPUB; USOCR; USPAT) - See Search History Printout	11/3/2009	/PB/		
EAST(US-PGPUB; USOCR; USPAT) - See Search History Printout	6/24/2010	/PB/		

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